# **BLC10G22XS-400AVT**

# Power LDMOS transistor

**AMPLEON** 

Rev. 1 — 30 April 2018

Product data sheet

## 1. Product profile

### 1.1 General description

400 W LDMOS packaged asymmetric Doherty power transistor for base station applications at frequencies from 2110 MHz to 2200 MHz.

#### Table 1. Typical performance

Typical RF performance at  $T_{case}$  = 25 °C in an asymmetrical Doherty production test circuit.  $V_{DS}$  = 28 V;  $I_{Dq}$  = 800 mA (main);  $V_{GS(amp)peak}$  = 1.0 V, unless otherwise specified.

Test signal	f	V <sub>DS</sub>	P <sub>L(AV)</sub>	G <sub>p</sub>	η <sub>D</sub>	ACPR
	(MHz)	(V)	(W)	(dB)	(%)	(dBc)
1-carrier W-CDMA	2110 to 2200	28	56	17.0	47.0	-29.6 <sup>[1]</sup>

<sup>[1]</sup> Test signal: 1-carrier W-CDMA; 3GPP test model 1; 64 DPCH; PAR = 9.6 dB at 0.01 % probability on CCDF.

### 1.2 Features and benefits

- Excellent ruggedness
- High efficiency
- Low thermal resistance providing excellent thermal stability
- Lower output capacitance for improved performance in Doherty applications
- Designed for low memory effects providing excellent digital pre-distortion capability
- Internally matched for ease of use
- Integrated ESD protection
- For RoHS compliance see the product details on the Ampleon website

### 1.3 Applications

 RF power amplifiers for base stations and multi carrier applications in the 2110 MHz to 2200 MHz frequency range

## 2. Pinning information

Table 2. Pinning

Pin	Description		Simplified outline	Graphic symbol
1	drain2 (peak)			0.7
2	drain1 (main)		7 2 1 6	2, 7
3	gate1 (main)		5	
4	gate2 (peak)		3 4	3——5
5	source	[1]		4—
6	video decoupling (peak)			' <del> </del>
7	video decoupling (main)			1, 6 aaa-014884

<sup>[1]</sup> Connected to flange.

## 3. Ordering information

Table 3. Ordering information

Type number	Package					
	Name	Description	Version			
BLC10G22XS-400AVT	-	air cavity plastic earless flanged package; 6 leads	SOT1258-4			

## 4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	drain-source voltage		-	65	V
V <sub>GS(amp)main</sub>	main amplifier gate-source voltage		-6	+9	V
V <sub>GS(amp)peak</sub>	peak amplifier gate-source voltage		-6	+9	V
T <sub>stg</sub>	storage temperature		-65	+150	°C
Tj	junction temperature	[1]	-	225	°C
T <sub>case</sub>	case temperature	operating [1]	<del>-4</del> 0	+125	°C

<sup>[1]</sup> Continuous use at maximum temperature will affect the reliability, for details refer to the online MTF calculator.

## 5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Тур	Unit
R <sub>th(j-c)</sub>	thermal resistance from junction to case	V <sub>DS</sub> = 28 V; I <sub>Dq</sub> = 800 mA (main); V <sub>GS(amp)peak</sub> = 1.0 V; T <sub>case</sub> = 80 °C		
		P <sub>L</sub> = 56 W	0.29	k/W
		P <sub>L</sub> = 74 W	0.27	k/W

BLC10G22XS-400AVT

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### 6. Characteristics

 Table 6.
 DC characteristics

 $T_i$  = 25 °C unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Main dev	rice					
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	$V_{GS} = 0 \text{ V}; I_D = 1.44 \text{ mA}$	65	-	-	V
V <sub>GS(th)</sub>	gate-source threshold voltage	V <sub>DS</sub> = 10 V; I <sub>D</sub> = 144 mA	1.5	2.0	2.5	V
$V_{GSq}$	gate-source quiescent voltage	$V_{DS}$ = 28 V; $I_{D}$ = 800 mA	-	2.2	-	V
I <sub>DSS</sub>	drain leakage current	V <sub>GS</sub> = 0 V; V <sub>DS</sub> = 32 V	-	-	2.8	μΑ
I <sub>DSX</sub>	drain cut-off current	$V_{GS} = V_{GS(th)} + 3.75 \text{ V}$	-	26.5	-	Α
I <sub>GSS</sub>	gate leakage current	V <sub>GS</sub> = 9 V; V <sub>DS</sub> = 0 V	-	-	280	nΑ
9 <sub>fs</sub>	forward transconductance	V <sub>DS</sub> = 10 V; I <sub>D</sub> = 7.2 A	-	15.0	-	S
R <sub>DS(on)</sub>	drain-source on-state resistance	$V_{GS} = V_{GS(th)} + 3.75 \text{ V};$ $I_D = 5.04 \text{ A}$	-	93	128	mΩ
Peak dev	rice					
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	$V_{GS} = 0 \text{ V}; I_D = 2.98 \text{ mA}$	65	-	-	V
V <sub>GS(th)</sub>	gate-source threshold voltage	$V_{DS}$ = 10 V; $I_{D}$ = 298 mA	1.5	2.0	2.5	V
$V_{GSq}$	gate-source quiescent voltage	V <sub>DS</sub> = 28 V; I <sub>D</sub> = 1600 mA	-	2.2	-	V
I <sub>DSS</sub>	drain leakage current	V <sub>GS</sub> = 0 V; V <sub>DS</sub> = 32 V	-	-	2.8	μΑ
I <sub>DSX</sub>	drain cut-off current	$V_{GS} = V_{GS(th)} + 3.75 \text{ V}$	-	47	-	Α
I <sub>GSS</sub>	gate leakage current	V <sub>GS</sub> = 11 V; V <sub>DS</sub> = 0 V	-	-	280	nA
g <sub>fs</sub>	forward transconductance	V <sub>DS</sub> = 10 V; I <sub>D</sub> = 14.9 A	-	28.5	-	S
R <sub>DS(on)</sub>	drain-source on-state resistance	$V_{GS} = V_{GS(th)} + 3.75 \text{ V};$ $I_D = 10.43 \text{ A}$	-	50	74	mΩ

#### Table 7. RF characteristics

Test signal: 1-carrier W-CDMA; PAR = 9.6 dB at 0.01 % probability on the CCDF; 3GPP test model 1; 1 to 64 DPCH;  $f_1$  = 2112.5 MHz;  $f_2$  = 2167.5 MHz; RF performance at  $V_{DS}$  = 28 V;  $I_{Dq}$  = 800 mA (main);  $V_{GS(amp)peak}$  = 1.0 V;  $T_{case}$  = 25 °C; unless otherwise specified; in an asymmetrical Doherty production test circuit at frequencies from 2110 MHz to 2200 MHz.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
G <sub>p</sub>	power gain	P <sub>L(AV)</sub> = 56 W	15.3	16.3	-	dB
RLin	input return loss	P <sub>L(AV)</sub> = 56 W	-	-14	-9	dB
$\eta_{D}$	drain efficiency	P <sub>L(AV)</sub> = 56 W	42	46	-	%
ACPR	adjacent channel power ratio	P <sub>L(AV)</sub> = 56 W	-	-29	-24	dBc

#### Table 8. RF characteristics

Test signal: 1-carrier W-CDMA; PAR = 9.6 dB at 0.01 % probability on the CCDF; 3GPP test model 1; 1 to 64 DPCH;  $f_1$  = 2112.5 MHz;  $f_2$  = 2167.5 MHz; RF performance at  $V_{DS}$  = 28 V;  $I_{Dq}$  = 800 mA (main);  $V_{GS(amp)peak}$  = 1.0 V;  $T_{case}$  = 25 °C; unless otherwise specified; in an asymmetrical Doherty production test circuit at a frequency of 2200 MHz.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
PARO	output peak-to-average ratio	P <sub>L(AV)</sub> = 56 W	6.3	6.9	-	dB
$P_{L(M)}$	peak output power	P <sub>L(AV)</sub> = 56 W	380	440	-	W

## 7. Test information

## 7.1 Ruggedness in Doherty operation

The BLC10G22XS-400AVT is capable of withstanding a load mismatch corresponding to VSWR = 10 : 1 through all phases under the following conditions:  $V_{DS}$  = 32 V;  $I_{Dq}$  = 800 mA;  $V_{GS(amp)peak}$  = 1.0 V; f = 2112.5 MHz;  $P_{L}$  = 155 W (5 dB OBO); 100 % clipping

## 7.2 Impedance information

Table 9. Typical impedance of main device

Measured load-pull data of main device;  $I_{Dq}$  = 800 mA (main);  $V_{DS}$  = 28 V; pulsed CW ( $t_p$  = 100  $\mu$ s;  $\delta$  = 10 %).

f	Z <sub>S</sub> [1]	Z <sub>L</sub> [1]	P <sub>L</sub> [2]	η <sub>D</sub> [2]	G <sub>p</sub> [2]
(MHz)	(Ω)	(Ω)	(W)	(%)	(dB)
Maximum	power load				
2110	1.6 – j6.1	1.5 – j2.9	205	61.5	17.2
2140	2.1 – j6.5	1.5 – j2.9	205	62.0	17.3
2170	2.6 – j7.0	1.4 – j3.3	205	60.0	17.2
Maximum	drain efficiency	load			
2110	1.6 – j6.1	2.4 – j2.4	160	68.0	19.1
2140	2.1 – j6.5	2.4 – j2.3	158	67.5	19.2
2170	2.6 – j7.0	2.0 – j2.2	160	67.0	19.1

<sup>[1]</sup>  $Z_S$  and  $Z_L$  defined in Figure 1.

<sup>[2]</sup> At 3 dB gain compression.

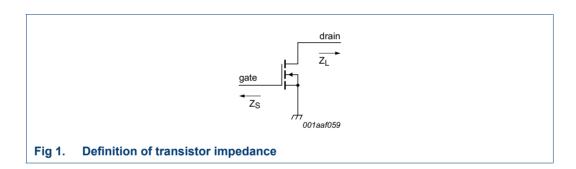
Table 10. Typical impedance of peak device

Measured load-pull data of peak device;  $I_{Dq}$  = 1600 mA (peak);  $V_{DS}$  = 28 V; pulsed CW ( $t_p$  = 100  $\mu$ s;  $\delta$  = 10 %).

f	Z <sub>S</sub> [1]	Z <sub>L</sub> [1]	P <sub>L</sub> [2]	η <sub>D</sub> [2]	G <sub>p</sub> [2]					
(MHz)	(Ω)	(Ω)	(W)	(%)	(dB)					
Maximum	Maximum power load									
2110	1.9 – j5.4	1.3 – j3.3	390	60.0	16.2					
2140	2.4 – j5.7	1.4 – j3.5	390	57.5	16.3					
2170	3.1 – j6.1	1.3 – j3.7	390	55.0	16.1					
Maximum	drain efficiency	load								
2110	1.9 – j5.4	1.8 – j2.7	340	63.6	17.6					
2140	2.4 – j5.7	1.9 – j2.6	315	63.4	18.1					
2170	3.1 – j6.1	1.9 – j2.7	320	63.6	18.2					

<sup>[1]</sup>  $Z_S$  and  $Z_L$  defined in Figure 1.

<sup>[2]</sup> At 3 dB gain compression.



## 7.3 Recommended impedances for Doherty design

#### Table 11. Typical impedance of main at 1:1 load

Measured load-pull data of main device;  $I_{Dq}$  = 800 mA (main);  $V_{DS}$  = 28 V; pulsed CW ( $t_p$  = 100  $\mu$ s;  $\delta$  = 10 %).

f	Z <sub>S</sub> [1]	Z <sub>L</sub> [1]	P <sub>L</sub> [2]	η <sub>D</sub> [2]	G <sub>p</sub> [2]
(MHz)	<b>(</b> Ω <b>)</b>	<b>(</b> Ω <b>)</b>	(W)	(%)	(dB)
2110	1.7 – j5.5	2.1 – j3.8	165	38.0	20.8
2140	2.0 – j5.8	2.1 – j3.5	170	38.0	20.8
2170	2.3 – j6.1	2.0 – j3.3	175	38.5	21.1

<sup>[1]</sup>  $Z_S$  and  $Z_L$  defined in Figure 1.

<sup>[2]</sup> At  $P_{L(AV)} = 56 \text{ W}$ .

#### Table 12. Typical impedance of main device at 1: 2.5 load

Measured load-pull data of main device;  $I_{Dq}$  = 800 mA (main);  $V_{DS}$  = 28 V; pulsed CW ( $t_p$  = 100  $\mu$ s;  $\delta$  = 10 %).

f	Z <sub>S</sub> [1]	Z <sub>L</sub> [1]	P <sub>L</sub> [2]	η <sub>D</sub> [2]	G <sub>p</sub> [2]
(MHz)	<b>(</b> Ω <b>)</b>	<b>(</b> Ω <b>)</b>	(W)	(%)	(dB)
2110	1.7 – j5.5	3.6 – j0.8	85	53.2	23.5
2140	2.0 – j5.8	3.5 – j0.6	78	53.4	23.5
2170	2.3 – j6.1	3.3 – j0.4	70	53.2	24.0

<sup>[1]</sup>  $Z_S$  and  $Z_L$  defined in Figure 1.

#### Table 13. Typical impedance of peak device at 1:1 load

Measured load-pull data of peak device;  $I_{Dq}$  = 1600 mA (peak);  $V_{DS}$  = 28 V; pulsed CW ( $t_p$  = 100  $\mu$ s;  $\delta$  = 10 %).

f	Z <sub>S</sub> [1]	Z <sub>L</sub> [1]	P <sub>L</sub> [2]	η <sub>D</sub> [2]	G <sub>p</sub> [2]
(MHz)	<b>(</b> Ω <b>)</b>	<b>(</b> Ω <b>)</b>	(W)	(%)	(dB)
2110	1.7 – j4.8	1.8 – j3.5	350	25.5	19.7
2140	2.0 - j5.0	1.8 – j3.2	345	25.8	19.9
2170	2.4 – j5.2	1.8 – j3.1	340	26.4	20.4

<sup>[1]</sup>  $Z_S$  and  $Z_L$  defined in Figure 1.

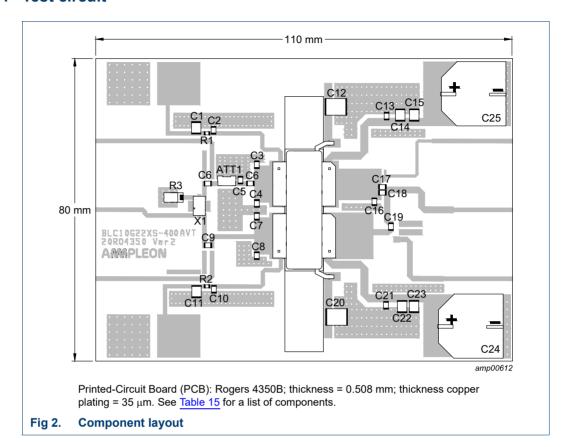
Table 14. Off-state impedances of peak device

f	Z <sub>off</sub>
(MHz)	(Ω)
2110	2.9 – j2.9
2140	2.3 – j1.8
2170	2.0 – j1.0

<sup>[2]</sup> At  $P_{L(AV)} = 56 \text{ W}$ .

<sup>[2]</sup> At  $P_{L(AV)} = 56 \text{ W}$ .

## 7.4 Test circuit

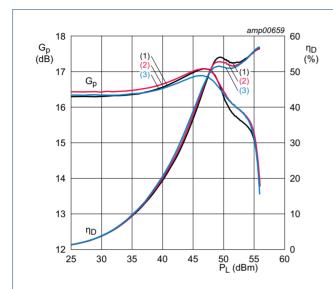


**Table 15. List of components** See Figure 2 for component layout.

Component	Description	Value	Remarks
C1, C11, C14, C15, C22, C23,	multilayer ceramic chip capacitor	10 μF, 50 V	Murata: GRM32ER71H106KA12L, SMD 1210
C2, C6, C9, C10, C13, C19, C21	multilayer ceramic chip capacitor	15 pF, 250 V	Murata: GQM2195C2E150FB15, SMD 805
C3, C4, C7, C8	multilayer ceramic chip capacitor	1.0 pF, 250 V	Murata: GQM2195C2E1ROBB15, SMD 0805
C5	multilayer ceramic chip capacitor	0.8 pF, 250 V	Murata: GQM2195C2E1ROBB15, SMD 0805
C12, C20	multilayer ceramic chip capacitor	4.7 μF, 100 V	C5750X7R2A475KT/A
C16	multilayer ceramic chip capacitor	0.5 pF, 250 V	Murata: GQM2195C2E1ROBB15, SMD 0805
C17, C18	multilayer ceramic chip capacitor	1.8 pF, 250 V	Murata: GQM2195C2E1R8BB15, SMD 0805
C24, C25	electrolytic capacitor	470 μF, 63 V	
R1, R2	resistor	5.1 Ω, 1 %	SMD 805
R3	resistor	50 Ω, 25 W	Anaren: C16A50Z4
X1	hybrid coupler	2 dB, 90°	Anaren: Xinger III, X3C20F1-02
ATT1	attenuator	1 dB	Anaren: D10AA1Z4

## 7.5 Graphical data

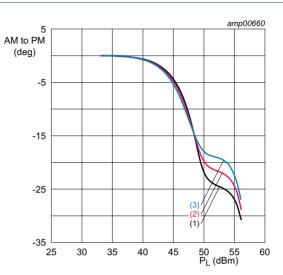
### 7.5.1 Pulsed CW



 $V_{DS}$  = 28 V;  $I_{Dq}$  = 800 mA;  $V_{GS(amp)peak}$  = 1.0 V.

- (1) f = 2210 MHz
- (2) f = 2140 MHz
- (3) f = 2170 MHz

Fig 3. Power gain and drain efficiency as function of output power; typical values



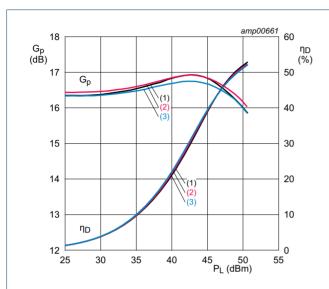
 $V_{DS}$  = 28 V;  $I_{Dq}$  = 800 mA;  $V_{GS(amp)peak}$  = 1.0 V.

- (1) f = 2210 MHz
- (2) f = 2140 MHz
- (3) f = 2170 MHz

Fig 4. Normalized AM to PM as a function of output power; typical values

#### 7.5.2 1-Carrier W-CDMA

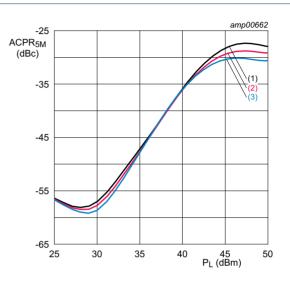
Test signal: 3GPP test model 1; 1 to 64 DPCH (100 % clipping): PAR = 7.5 dB per carrier at 0.01 % probability on CCDF per carrier.



 $V_{DS}$  = 28 V;  $I_{Dq}$  = 800 mA;  $V_{GS(amp)peak}$  = 1.0 V.

- (1) f = 2210 MHz
- (2) f = 2140 MHz
- (3) f = 2170 MHz

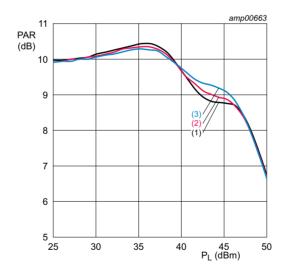
Fig 5. Power gain and drain efficiency as function of output power; typical values



 $V_{DS} = 28 \text{ V}; I_{Dq} = 800 \text{ mA}; V_{GS(amp)peak} = 1.0 \text{ V}.$ 

- (1) f = 2210 MHz
- (2) f = 2140 MHz
- (3) f = 2170 MHz

Fig 6. Adjacent channel power ratio (5 MHz) as a function of output power; typical values



 $V_{DS} = 28 \text{ V}; I_{Dq} = 800 \text{ mA}; V_{GS(amp)peak} = 1.0 \text{ V}.$ 

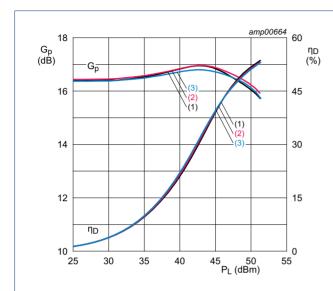
- (1) f = 2210 MHz
- (2) f = 2140 MHz
- (3) f = 2170 MHz

Fig 7. Peak-to-average power ratio as a function of output power; typical values

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#### 7.5.3 2-Carrier W-CDMA

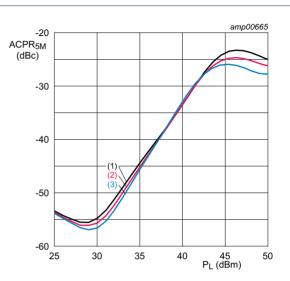
Test signal: 3GPP test model 1; 1 to 64 DPCH (46 % clipping): PAR = 7.5 dB per carrier at 0.01 % probability on CCDF per carrier.



 $V_{DS}$  = 28 V;  $I_{Dq}$  = 800 mA;  $V_{GS(amp)peak}$  = 1.0 V.

- (1) f = 2210 MHz
- (2) f = 2140 MHz
- (3) f = 2170 MHz

Fig 8. Power gain and drain efficiency as function of output power; typical values

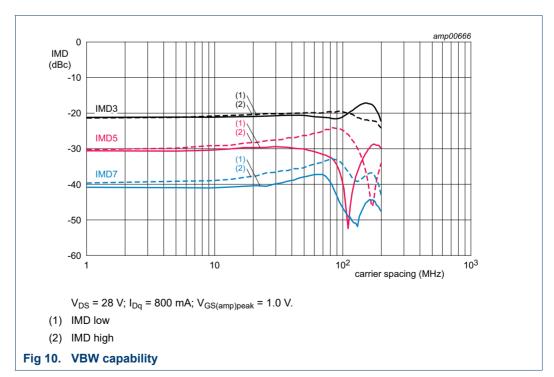


 $V_{DS}$  = 28 V;  $I_{Dq}$  = 800 mA;  $V_{GS(amp)peak}$  = 1.0 V.

- (1) f = 2210 MHz
- (2) f = 2140 MHz
- (3) f = 2170 MHz

Fig 9. Adjacent channel power ratio (5 MHz) as a function of output power; typical values

#### 7.5.4 2-Tone VBW

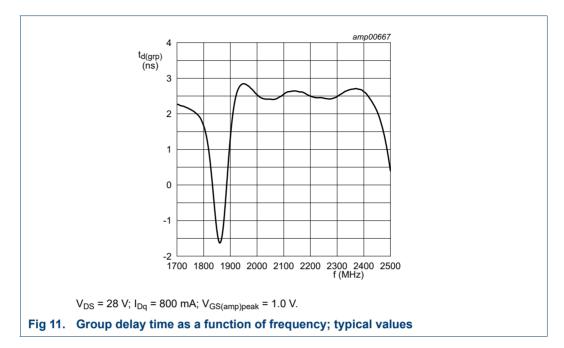


BLC10G22XS-400AVT

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### 7.5.5 Group delay



## 8. Package outline

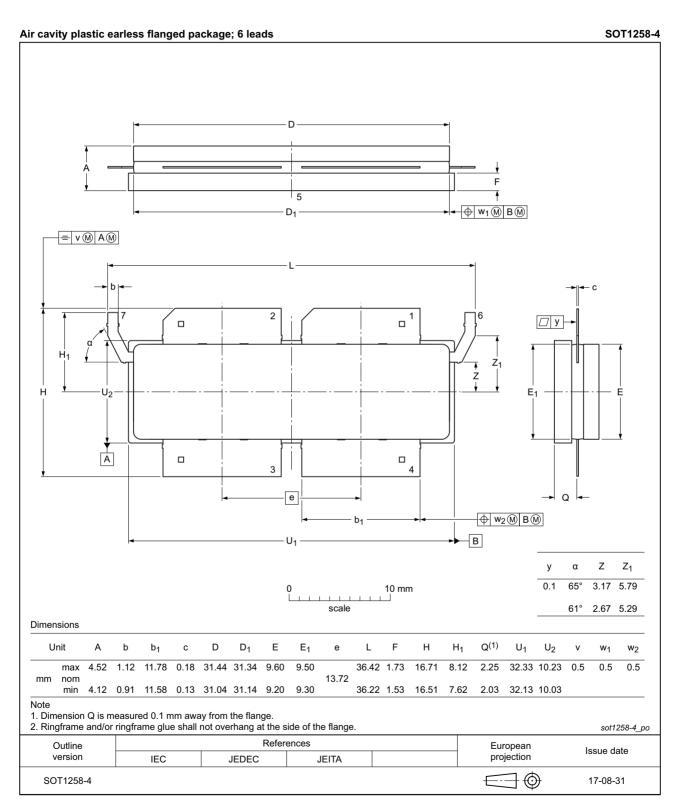


Fig 12. Package outline SOT1258-4

BLC10G22XS-400AVT

## 9. Handling information

#### **CAUTION**



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the ANSI/ESD S20.20, IEC/ST 61340-5, JESD625-A or equivalent standards.

Table 16. ESD sensitivity

ESD model	Class
Charged Device Model (CDM); According to ANSI/ESDA/JEDEC standard JS-002	C3 [1]
Human Body Model (HBM); According to ANSI/ESDA/JEDEC standard JS-001	2 [2]

- [1] CDM classification C3 is granted to any part that passes after exposure to an ESD pulse of 1000 V.
- [2] HBM classification 2 is granted to any part that passes after exposure to an ESD pulse of 2000 V, but fails after exposure to an ESD pulse of 4000 V.

### 10. Abbreviations

Table 17. Abbreviations

Acronym	Description
3GPP	3rd Generation Partnership Project
CCDF	Complementary Cumulative Distribution Function
CW	Continuous Wave
DPCH	Dedicated Physical CHannel
ESD	ElectroStatic Discharge
LDMOS	Laterally Diffused Metal-Oxide Semiconductor
MTF	Median Time to Failure
ОВО	Output Back Off
PAR	Peak-to-Average Ratio
RoHS	Restriction of Hazardous Substances
SMD	Surface Mounted Device
VSWR	Voltage Standing Wave Ratio
W-CDMA	Wideband Code Division Multiple Access

## 11. Revision history

Table 18. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BLC10G22XS-400AVT v.1	20180430	Product data sheet	-	-

## 12. Legal information

#### 12.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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- [2] The term 'short data sheet' is explained in section "Definitions"
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BLC10G22XS-400AVT

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## BLC10G22XS-400AVT

#### **Power LDMOS transistor**

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#### **Power LDMOS transistor**

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